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Details

Product Status	Active
Core Processor	ARM® Cortex®-M0+
Core Size	32-Bit Single-Core
Speed	48MHz
Connectivity	I ² C, FlexIO, SPI, UART/USART, USB
Peripherals	DMA, I ² S, PWM, WDT
Number of I/O	51
Program Memory Size	64KB (64K x 8)
Program Memory Type	FLASH
EEPROM Size	-
RAM Size	16K x 8
Voltage - Supply (Vcc/Vdd)	1.71V ~ 3.6V
Data Converters	A/D 17x16b
Oscillator Type	Internal
Operating Temperature	-40°C ~ 105°C (TA)
Mounting Type	Surface Mount
Package / Case	64-LQFP
Supplier Device Package	64-LQFP (10x10)
Purchase URL	https://www.e-xfl.com/product-detail/nxp-semiconductors/mkl27z64vlh4

1 Ordering information

The following chips are available for ordering.

Table 1. Ordering information

Product		Memory		Package		IO and ADC channel		
Part number	Marking (Line1/Line2)	Flash (KB)	SRAM (KB)	Pin count	Package	GPIOs	GPIOs (INT/HD) ¹	ADC channels (SE/DP)
MKL27Z64VLH4	MKL27Z64 / VLH4	64	16	64	LQFP	51	51/6	17/2
MKL27Z32VLH4	MKL27Z32 / VLH4	32	8	64	LQFP	51	51/6	17/2
MKL27Z64VDA4	M27M6	64	16	36	XFBGA	30	30/6	14/3
MKL27Z32VDA4	M27M5	32	8	36	XFBGA	30	30/6	14/3
MKL27Z64VFM4	M27M6V	64	16	32	QFN	24	24/6	8/0
MKL27Z32VFM4	M27M5V	32	8	32	QFN	24	24/6	8/0
MKL27Z64VMP4	TBD	64	16	64	MAPBGA	51	51/6	17/2
MKL27Z32VMP4	TBD	32	8	64	MAPBGA	51	51/6	17/2
MKL27Z64VFT4	TBD	64	16	48	QFN	37	37/6	15/1
MKL27Z32VFT4	TBD	32	8	48	QFN	37	37/6	15/1

1. INT: interrupt pin numbers; HD: high drive pin numbers

NOTE

The 48 QFN and 64 MAPBGA packages supporting MKLx7ZxxVFT4 and MKLx7ZxxVMP4 part numbers for this product are not yet available. However, these packages are included in Package Your Way program for Kinetis MCUs. Visit Freescale.com/KPYW for more details.

2 Overview

The following figure shows the system diagram of this device

2.1.1 ARM Cortex-M0+ core

The enhanced ARM Cortex M0+ is the member of the Cortex-M series of processors targeting microcontroller cores focused on very cost sensitive, low power applications. It has a single 32-bit AMBA AHB-Lite interface and includes an NVIC component. It also has hardware debug functionality including support for simple program trace capability. The processor supports the ARMv6-M instruction set (Thumb) architecture including all but three 16-bit Thumb opcodes (52 total) plus seven 32-bit instructions. It is upward compatible with other Cortex-M profile processors.

2.1.2 NVIC

The Nested Vectored Interrupt Controller supports nested interrupts and 4 priority levels for interrupts. In the NVIC, each source in the IPR registers contains two bits. It also differs in number of interrupt sources and supports 32 interrupt vectors.

The Cortex-M family uses a number of methods to improve interrupt latency to up to 15 clock cycles for Cortex-M0+. It also can be used to wake the MCU core from Wait and VLPW modes.

2.1.3 AWIC

The asynchronous wake-up interrupt controller (AWIC) is used to detect asynchronous wake-up events in Stop mode and signal to clock control logic to resume system clocking. After clock restarts, the NVIC observes the pending interrupt and performs the normal interrupt or event processing. The AWIC can be used to wake MCU core from Stop and VLPS modes.

Wake-up sources are listed as below:

Table 2. AWIC stop wake-up sources

Wake-up source	Description
Available system resets	RESET pin with filter mode disabled or enabled when LPO is its clock source, COP when its clock source is enabled. COP can also work when its clock source is enabled during Stop mode.
Low-voltage detect	Power management controller—functional in Stop mode
Low-voltage warning	Power management controller—functional in Stop mode
Pin interrupts	Port control module—any enabled pin interrupt is capable of waking the system
ADC	The ADC is functional when using internal clock source or external crystal clock
CMP0	Interrupt in normal or trigger mode

Table continues on the next page...

Table 4. Module clocks (continued)

Module	Bus interface clock	Internal clocks	I/O interface clocks
I ² C1	System Clock	—	I2C1_SCL
LPUART0, LPUART1	Bus clock	LPUART0 clock LPUART1 clock	—
UART2	Bus clock	—	—
FlexIO	Bus clock	FlexIO clock	—
Human-machine interfaces			
GPIO	Platform clock	—	—

2.1.7 Security

Security state can be enabled via programming flash configuration field (0x40e). After enabling device security, the SWD port cannot access the memory resources of the MCU, and ROM boot loader is also limited to access flash and not allowed to read out flash information via ROM boot loader commands.

Access interface	Secure state	Unsecure operation
SWD port	Cannot access memory source by SWD interface	The debugger can write to the Flash Mass Erase in Progress field of the MDM-AP Control register to trigger a mass erase (Erase All Blocks) command
ROM boot loader Interface (UART/I2C/SPI/USB)	Limit access to the flash, cannot read out flash content	Send "FlashEraseAllUnsecureh" command or attempt to unlock flash security using the backdoor key

This device features 80-bit unique identification number, which is programmed in factory and loaded to SIM register after power-on reset.

2.1.8 Power management

The Power Management Controller (PMC) expands upon ARM's operational modes of Run, Sleep, and Deep Sleep, to provide multiple configurable modes. These modes can be used to optimize current consumption for a wide range of applications. The WFI or WFE instruction invokes a Wait or a Stop mode, depending on the current configuration. For more information on ARM's operational modes, See the ARM® Cortex User Guide.

2.2.6 CMP

The device contains one high-speed comparator and two 8-input multiplexers for both the inverting and non-inverting inputs of the comparator. Each CMP input channel connects to both muxes.

The CMP includes one 6-bit DAC, which provides a selectable voltage reference for various user application cases. Besides, the CMP also has several module-to-module interconnects in order to facilitate ADC triggering, TPM triggering, and interfaces.

The CMP has the following features:

- Inputs may range from rail to rail
- Programmable hysteresis control
- Selectable interrupt on rising-edge, falling-edge, or both rising or falling edges of the comparator output
- Selectable inversion on comparator output
- Capability to produce a wide range of outputs such as sampled, digitally filtered
- External hysteresis can be used at the same time that the output filter is used for internal functions
- Two software selectable performance levels: shorter propagation delay at the expense of higher power and Low power with longer propagation delay
- DMA transfer support
- Functional in all modes of operation except in VLLS0 mode
- The filter functions are not available in Stop, VLPS, LLS, or VLLSx modes
- Integrated 6-bit DAC with selectable supply reference source and can be power down to conserve power
- Two 8-to-1 channel mux

2.2.7 RTC

The RTC is an always powered-on block that remains active in all low power modes. The time counter within the RTC is clocked by a 32.768 kHz clock sourced from an external crystal using the oscillator or clock directly from RTC_CLKIN pin.

RTC is reset on power-on reset, and a software reset bit in RTC can also initialize all RTC registers.

The RTC module has the following features

- 32-bit seconds counter with roll-over protection and 32-bit alarm

- 1/16 bit-time noise detection
- DMA interface

2.2.12 LPUART

This product contains two Low-Power UART modules, both of their clock sources are selectable from IRC48M, IRC8M/2M or external crystal clock, and can work in Stop and VLPS modes. They also support 4× to 32× data oversampling rate to meet different applications.

The LPUART module has the following features:

- Programmable baud rates (13-bit modulo divider) with configurable oversampling ratio from 4× to 32×
- Transmit and receive baud rate can operate asynchronous to the bus clock and can be configured independently of the bus clock frequency, support operation in Stop mode
- Interrupt, DMA or polled operation
- Hardware parity generation and checking
- Programmable 8-bit, 9-bit or 10-bit character length
- Programmable 1-bit or 2-bit stop bits
- Three receiver wakeup methods
 - Idle line wakeup
 - Address mark wakeup
 - Receive data match
- Automatic address matching to reduce ISR overhead:
 - Address mark matching
 - Idle line address matching
 - Address match start, address match end
- Optional 13-bit break character generation / 11-bit break character detection
- Configurable idle length detection supporting 1, 2, 4, 8, 16, 32, 64 or 128 idle characters
- Selectable transmitter output and receiver input polarity

2.2.13 SPI

This device contains two SPI modules. SPI modules support 8-bit and 16-bit modes. FIFO function is available only on SPI1 module.

The SPI modules have the following features:

- Full-duplex or single-wire bidirectional mode
- Programmable transmit bit rate
- Double-buffered transmit and receive data register
- Serial clock phase and polarity options
- Slave select output
- Mode fault error flag with CPU interrupt capability
- Control of SPI operation during wait mode
- Selectable MSB-first or LSB-first shifting
- Programmable 8- or 16-bit data transmission length
- Receive data buffer hardware match feature
- 64-bit FIFO mode for high speed/large amounts of data transfers
- Support DMA

2.2.14 I2C

This device contains two I2C modules, which support up to 1 Mbits/s by dual buffer features, and address match to wake MCU from the low power mode.

I2C modules support DMA transfer, and the interrupt condition can trigger DMA request when DMA function is enabled.

The I2C modules have the following features:

- Support for system management bus (SMBus) Specification, version 2
- Software programmable for one of 64 different serial clock frequencies
- Software-selectable acknowledge bit
- Arbitration-lost interrupt with automatic mode switching from master to slave
- Calling address identification interrupt
- START and STOP signal generation and detection
- Repeated START signal generation and detection
- Acknowledge bit generation and detection
- Bus busy detection
- General call recognition
- 10-bit address extension
- Programmable input glitch filter
- Low power mode wakeup on slave address match
- Range slave address support
- DMA support
- Double buffering support to achieve higher baud rate

- Configurable edge(rising,falling,both) or level sensitive interrupt type
- Support DMA request
- Asynchronous wake-up in low-power modes
- Configurable pullup, pulldown, and pull-disable on select pins
- Configurable high and low drive strength on selected pins
- Configurable fast and slow slew rates on selected pins
- Configurable passive filter on selected pins
- Individual mux control field supporting analog or pin disabled, GPIO, and up to chip-specific digital functions
- Pad configuration fields are functional in all digital pin muxing modes.

The GPIO module has the following features:

- Port Data Input register visible in all digital pin-multiplexing modes
- Port Data Output register with corresponding set/clear/toggle registers
- Port Data Direction register
- GPIO support single-cycle access via fast GPIO.

3 Memory map

This device contains various memories and memory-mapped peripherals which are located in a 4 GB memory space. The following figure shows the system memory and peripheral locations

NOTE

The 48 QFN and 64 MAPBGA packages for this product are not yet available. However, these packages are included in Package Your Way program for Kinetis MCUs. Visit freescale.com/KPYW for more details.

64 LQFP	36 XFBGA	32 QFN	48 QFN	64 MAPBGA	Pin Name	Default	ALT0	ALT1	ALT2	ALT3	ALT4	ALT5	ALT6	ALT7
—	C1	—	—	—	PTE17	ADC0_DM1/ ADC0_SE5a	ADC0_DM1/ ADC0_SE5a	PTE17	SPI0_SCK	UART2_RX	TPM_CLKIN1	LPTMR0_ALT3	FXIO0_D1	
—	D1	—	—	—	PTE18	ADC0_DP2/ ADC0_SE2	ADC0_DP2/ ADC0_SE2	PTE18	SPI0_MOSI		I2C0_SDA	SPI0_MISO	FXIO0_D2	
—	F2	9	—	—	VREF0	VREF0_B	VREF0_B							
—	—	—	—	C5	NC	NC	NC							
1	A1	1	—	A1	PTE0	DISABLED		PTE0/ CLKOUT32K	SPI1_MISO	LPUART1_TX	RTC_CLKOUT	CMP0_OUT	I2C1_SDA	
2	—	—	—	B1	PTE1	DISABLED		PTE1	SPI1_MOSI	LPUART1_RX		SPI1_MISO	I2C1_SCL	
3	—	—	1	—	VDD	VDD	VDD							
4	C4	2	2	C4	VSS	VSS	VSS							
5	B1	3	3	E1	USB0_DP	USB0_DP	USB0_DP							
6	D2	4	4	D1	USB0_DM	USB0_DM	USB0_DM							
7	C3	5	5	E2	USB_VDD	USB_VDD	USB_VDD							
8	C2	6	6	D2	PTE16	ADC0_DP1/ ADC0_SE1	ADC0_DP1/ ADC0_SE1	PTE16	SPI0_PCS0	UART2_TX	TPM_CLKIN0		FXIO0_D0	
9	E3	—	7	G1	PTE20	ADC0_DP0/ ADC0_SE0	ADC0_DP0/ ADC0_SE0	PTE20		TPM1_CH0	LPUART0_TX		FXIO0_D4	
10	E2	—	8	F1	PTE21	ADC0_DM0/ ADC0_SE4a	ADC0_DM0/ ADC0_SE4a	PTE21		TPM1_CH1	LPUART0_RX		FXIO0_D5	
11	E1	—	—	G2	PTE22	ADC0_DP3/ ADC0_SE3	ADC0_DP3/ ADC0_SE3	PTE22		TPM2_CH0	UART2_TX		FXIO0_D6	
12	F1	—	—	F2	PTE23	ADC0_DM3/ ADC0_SE7a	ADC0_DM3/ ADC0_SE7a	PTE23		TPM2_CH1	UART2_RX		FXIO0_D7	
13	D3	7	9	F4	VDDA	VDDA	VDDA							
14	D3	7	10	G4	VREFH	VREFH	VREFH							
14	—	—	10	G4	VREF0	VREF0_A	VREF0_A							
15	D4	8	11	G3	VREFL	VREFL	VREFL							
16	D4	8	12	F3	VSSA	VSSA	VSSA							
17	—	—	13	H1	PTE29	CMP0_IN5/ ADC0_SE4b	CMP0_IN5/ ADC0_SE4b	PTE29		TPM0_CH2	TPM_CLKIN0			
18	F2	9	14	H2	PTE30	ADC0_SE23/ CMP0_IN4	ADC0_SE23/ CMP0_IN4	PTE30		TPM0_CH3	TPM_CLKIN1	LPUART1_TX	LPTMR0_ALT1	
19	—	—	—	H3	PTE31	DISABLED		PTE31		TPM0_CH4				

64 LQFP	36 XFBGA	32 QFN	48 QFN	64 MAPBGA	Pin name	Driver strength	Default status after POR	Pullup/ pulldown setting after POR	Slew rate after POR	Passive pin filter after POR	Open drain	Pin interrupt
—	F2	9	—	—	VREF0	—	—	—	—	—	—	—
—	—	—	—	C5	NC	—	—	—	—	—	—	—
1	A1	1	—	A1	PTE0	ND	Hi-Z	—	FS	N	N	Y
2	—	—	—	B1	PTE1	ND	Hi-Z	—	FS	N	N	Y
3	—	—	1	—	VDD	—	—	—	—	—	—	—
4	C4	2	2	C4	VSS	—	—	—	—	—	—	—
5	B1	3	3	E1	USB0_DP	—	—	—	—	—	—	—
6	D2	4	4	D1	USB0_DM	—	—	—	—	—	—	—
7	C3	5	5	E2	USB_VDD	—	—	—	—	—	—	—
8	C2	6	6	D2	PTE16	ND	Hi-Z	—	FS	N	N	Y
9	E3	—	7	G1	PTE20	ND	Hi-Z	—	SS	N	N	Y
10	E2	—	8	F1	PTE21	ND	Hi-Z	—	SS	N	N	Y
11	E1	—	—	G2	PTE22	ND	Hi-Z	—	SS	N	N	Y
12	F1	—	—	F2	PTE23	ND	Hi-Z	—	SS	N	N	Y
13	D3	7	9	F4	VDDA	—	—	—	—	—	—	—
14	D3	7	10	G4	VREFH	—	—	—	—	—	—	—
14	—	—	10	G4	VREFO	—	—	—	—	—	—	—
15	D4	8	11	G3	VREFL	—	—	—	—	—	—	—
16	D4	8	12	F3	VSSA	—	—	—	—	—	—	—
17	—	—	13	H1	PTE29	ND	Hi-Z	—	SS	N	N	Y
18	F2	9	14	H2	PTE30	ND	Hi-Z	—	SS	N	N	Y
19	—	—	—	H3	PTE31	ND	Hi-Z	—	SS	N	N	Y
20	—	—	15	H4	PTE24	ND	Hi-Z	—	SS	N	N	Y
21	—	—	16	H5	PTE25	ND	Hi-Z	—	SS	N	N	Y
22	F3	10	17	D3	PTA0	ND	L	PD	SS	N	N	Y
23	F4	11	18	D4	PTA1	ND	Hi-Z	—	SS	N	N	Y
24	E4	12	19	E5	PTA2	ND	Hi-Z	—	SS	N	N	Y
25	E5	13	20	D5	PTA3	ND	H	PU	FS	N	N	Y
26	F5	14	21	G5	PTA4	ND	H	PU	SS	Y	N	Y

Table continues on the next page...

NOTE

The 48 QFN package for this product is not yet available. However, it is included in Package Your Way program for Kinetis MCUs. Visit freescale.com/KPYW for more details.

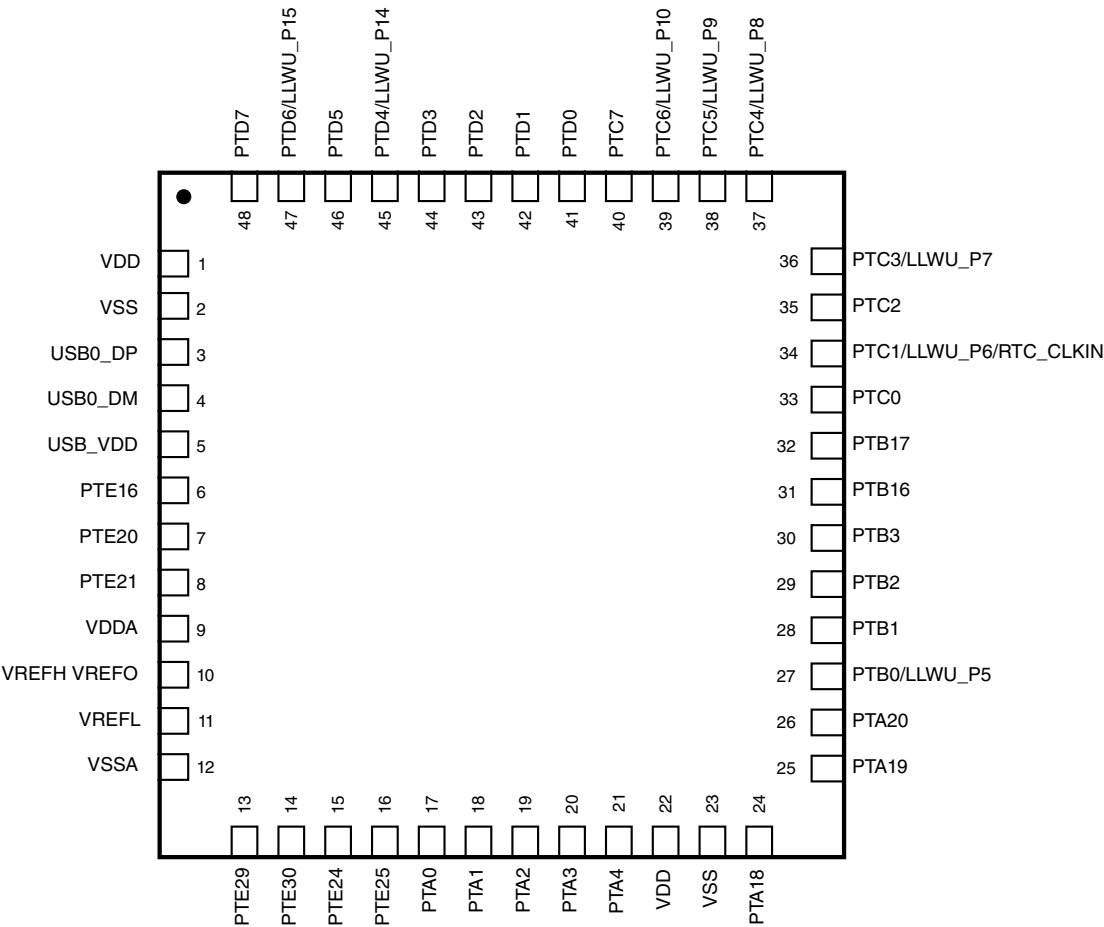


Figure 7. 48 QFN Pinout diagram (transparent top view)

The figure below shows the 64 MAPBGA pinouts.

NOTE

The 64 MAPBGA package for this product is not yet available. However, it is included in Package Your Way program for Kinetis MCUs. Visit freescale.com/KPYW for more details.

	1	2	3	4	5	6	
A	PTE0	PTD7	PTD4/ LLWU_P14	PTC7	PTC5/ LLWU_P9	PTC4/ LLWU_P8	A
B	USB0_DP	PTD6/ LLWU_P15	PTD5	PTC6/ LLWU_P10	PTC3/ LLWU_P7	PTC2	B
C	PTE17	PTE16	USB_VDD/ VDD	VSS	PTC1/ LLWU_P6/ RTC_CLKIN	PTB1	C
D	PTE18	USB0_DM	VDDA/ VREFH	VREFL/ VSSA	PTA20	PTB0/ LLWU_P5	D
E	PTE22	PTE21	PTE20	PTA2	PTA3	PTA19	E
F	PTE23	VREF0/ PTE30	PTA0	PTA1	PTA4	PTA18	F
	1	2	3	4	5	6	

Figure 10. 36 XFBGA Pinout diagram (transparent top view)

4.5 Package dimensions

The following figures show the dimensions of the package options for the devices supported by this document.

Table 39. Power consumption operating behaviors (continued)

Symbol	Description	Min.	Typ.	Max.	Unit	Notes
	<ul style="list-style-type: none"> at 50°C at 70°C at 85°C at 105 °C 	—	2.21	2.80	μA	
I _{DD_VLLS0}	Very-low-leakage stop mode 0 current all peripheral disabled (SMC_STOPCTRL[PORPO] = 0) at 3.0 V <ul style="list-style-type: none"> at 25 °C and below at 50 °C at 70 °C at 85 °C at 105 °C 	—	262	360	nA	
		—	593	725		
		—	1430	2014		
		—	2930	3514		
			7930	9895		
I _{DD_VLLS0}	Very-low-leakage stop mode 0 current all peripheral disabled (SMC_STOPCTRL[PORPO] = 1) at 3 V <ul style="list-style-type: none"> at 25 °C and below at 50 °C at 70 °C at 85 °C at 105 °C 	—	87	185	nA	4
		—	417	549		
		—	1230	1230		
		—	2720	3304		
			7780	9745		

- The analog supply current is the sum of the active or disabled current for each of the analog modules on the device. See each module's specification for its supply current.
- MCG_Lite configured for HIRC mode. CoreMark benchmark compiled using IAR 7.10 with optimization level high, optimized for balanced.
- RTC uses external 32 kHz crystal as clock source, and the current includes ERCLK32K power consumption.
- No brownout

Table 40. Low power mode peripheral adders — typical value

Symbol	Description	Temperature (°C)						Unit
		-40	25	50	70	85	105	
I _{IRC8MHz}	8 MHz internal reference clock (IRC) adder. Measured by entering STOP or VLPS mode with 8 MHz IRC enabled, MCG_SC[FCRDIV]=000b, MCG_MC[LIRC_DIV2]=000b.	77	77	77	77	77	77	μA
I _{IRC2MHz}	2 MHz internal reference clock (IRC) adder. Measured by entering STOP mode with the 2 MHz IRC enabled, MCG_SC[FCRDIV]=000b, MCG_MC[LIRC_DIV2]=000b.	25	25	25	25	25	25	μA

Table continues on the next page...

Table 45. Thermal attributes

Board type	Symbol	Description	32 QFN	36 XFBGA	64 LQFP	Unit	Notes
Single-layer (1S)	$R_{\theta JA}$	Thermal resistance, junction to ambient (natural convection)	101	81.5	71	°C/W	1, 2, 3
Four-layer (2s2p)	$R_{\theta JA}$	Thermal resistance, junction to ambient (natural convection)	33	54.7	53	°C/W	1, 2, 3, 4
Single-layer (1S)	$R_{\theta JMA}$	Thermal resistance, junction to ambient (200 ft./min. air speed)	84	71.3	60	°C/W	1, 4, 5
Four-layer (2s2p)	$R_{\theta JMA}$	Thermal resistance, junction to ambient (200 ft./min. air speed)	28	50.0	47	°C/W	1, 4, 5
—	$R_{\theta JB}$	Thermal resistance, junction to board	13	58.0	35	°C/W	6
—	$R_{\theta JC}$	Thermal resistance, junction to case	1.7	45.3	21	°C/W	7
—	Ψ_{JT}	Thermal characterization parameter, junction to package top outside center (natural convection)	3	1.2	5	°C/W	8
—	Ψ_{JB}	Thermal characterization parameter, junction to package bottom (natural convection)	-	44.5	-	°C/W	9

1. Junction temperature is a function of die size, on-chip power dissipation, package thermal resistance, mounting site (board) temperature, ambient temperature, air flow, power dissipation of other components on the board, and board thermal resistance.
2. Per SEMI G38-87 and JEDEC JESD51-2 with the single layer board horizontal.
3. Per JEDEC JESD51-2 with natural convection for horizontally oriented board. Board meets JESD51-9 specification for 1s or 2s2p board, respectively.
4. Per JEDEC JESD51-6 with the board horizontal.
5. Per JEDEC JESD51-6 with forced convection for horizontally oriented board. Board meets JESD51-9 specification for 1s or 2s2p board, respectively.
6. Thermal resistance between the die and the printed circuit board per JEDEC JESD51-8. Board temperature is measured on the top surface of the board near the package.
7. Thermal resistance between the die and the case top surface as measured by the cold plate method (MIL SPEC-883 Method 1012.1).
8. Thermal characterization parameter indicating the temperature difference between package top and the junction temperature per JEDEC JESD51-2. When Greek letters are not available, the thermal characterization parameter is written as Psi-JT.
9. Thermal characterization parameter indicating the temperature difference between package bottom center and the junction temperature per JEDEC JESD51-12. When Greek letters are not available, the thermal characterization parameter is written as Psi-JB.

5.3 Peripheral operating requirements and behaviors

5.3.1 Core modules

5.3.3.2.2 Oscillator frequency specifications

Table 50. Oscillator frequency specifications

Symbol	Description	Min.	Typ.	Max.	Unit	Notes
f_{osc_lo}	Oscillator crystal or resonator frequency — low-frequency mode (MCG_C2[RANGE]=00)	32	—	40	kHz	
$f_{osc_hi_1}$	Oscillator crystal or resonator frequency — high-frequency mode (low range) (MCG_C2[RANGE]=01)	3	—	8	MHz	
$f_{osc_hi_2}$	Oscillator crystal or resonator frequency — high frequency mode (high range) (MCG_C2[RANGE]=1x)	8	—	32	MHz	
f_{ec_extal}	Input clock frequency (external clock mode)	—	—	48	MHz	1, 2
t_{dc_extal}	Input clock duty cycle (external clock mode)	40	50	60	%	
t_{cst}	Crystal startup time — 32 kHz low-frequency, low-power mode (HGO=0)	—	750	—	ms	3, 4
	Crystal startup time — 32 kHz low-frequency, high-gain mode (HGO=1)	—	250	—	ms	
	Crystal startup time — 8 MHz high-frequency (MCG_C2[RANGE]=01), low-power mode (HGO=0)	—	0.6	—	ms	
	Crystal startup time — 8 MHz high-frequency (MCG_C2[RANGE]=01), high-gain mode (HGO=1)	—	1	—	ms	

1. Other frequency limits may apply when external clock is being used as a reference for the FLL
2. When transitioning from FEI or FBI to FBE mode, restrict the frequency of the input clock so that, when it is divided by FRDIV, it remains within the limits of the DCO input clock frequency.
3. Proper PC board layout procedures must be followed to achieve specifications.
4. Crystal startup time is defined as the time between the oscillator being enabled and the OSCINIT bit in the MCG_S register being set.

5.3.4 Memories and memory interfaces

5.3.4.1 Flash electrical specifications

This section describes the electrical characteristics of the flash memory module.

5.3.4.1.1 Flash timing specifications — program and erase

The following specifications represent the amount of time the internal charge pumps are active and do not include command overhead.

5.3.6.1.2 16-bit ADC electrical characteristics

Table 56. 16-bit ADC characteristics ($V_{REFH} = V_{DDA}$, $V_{REFL} = V_{SSA}$)

Symbol	Description	Conditions ¹	Min.	Typ. ²	Max.	Unit	Notes
I_{DDA_ADC}	Supply current		0.215	—	1.7	mA	3
f_{ADACK}	ADC asynchronous clock source	<ul style="list-style-type: none"> • ADLPC = 1, ADHSC = 0 • ADLPC = 1, ADHSC = 1 • ADLPC = 0, ADHSC = 0 • ADLPC = 0, ADHSC = 1 	1.2 2.4 3.0 4.4	2.4 4.0 5.2 6.2	3.9 6.1 7.3 9.5	MHz MHz MHz MHz	$t_{ADACK} = 1/f_{ADACK}$
	Sample Time	See Reference Manual chapter for sample times					
TUE	Total unadjusted error	<ul style="list-style-type: none"> • 12-bit modes • <12-bit modes 	— —	± 2 ± 1.4	± 6.8 ± 2.1	LSB ⁴	5
DNL	Differential non-linearity	<ul style="list-style-type: none"> • 12-bit modes • <12-bit modes 	— —	± 0.7 ± 0.2	–1.1 to +1.9 –0.3 to 0.5	LSB ⁴	5
INL	Integral non-linearity	<ul style="list-style-type: none"> • 12-bit modes • <12-bit modes 	— —	± 0.9 ± 0.4	–2.7 to +1.9 –0.7 to +0.5	LSB ⁴	5
E_{FS}	Full-scale error	<ul style="list-style-type: none"> • 12-bit modes • <12-bit modes 	— —	–4 –1.4	–5.4 –1.8	LSB ⁴	$V_{ADIN} = V_{DDA}$ ⁵
E_Q	Quantization error	<ul style="list-style-type: none"> • 16-bit modes • ≤ 13-bit modes 	— —	–1 to 0 —	— ± 0.5	LSB ⁴	
ENOB	Effective number of bits	16-bit differential mode <ul style="list-style-type: none"> • Avg = 32 • Avg = 4 16-bit single-ended mode <ul style="list-style-type: none"> • Avg = 32 • Avg = 4 	12.8 11.9 12.2 11.4	14.5 13.8 13.9 13.1	— — — —	bits bits bits bits	6
SINAD	Signal-to-noise plus distortion	See ENOB	$6.02 \times \text{ENOB} + 1.76$			dB	
THD	Total harmonic distortion	16-bit differential mode <ul style="list-style-type: none"> • Avg = 32 16-bit single-ended mode	— —	–94 –85	— —	dB dB	7

Table continues on the next page...

This device cannot support Host mode operation.

5.5.2 SPI switching specifications

The Serial Peripheral Interface (SPI) provides a synchronous serial bus with master and slave operations. Many of the transfer attributes are programmable. The following tables provide timing characteristics for classic SPI timing modes. See the SPI chapter of the chip's Reference Manual for information about the modified transfer formats used for communicating with slower peripheral devices.

All timing is shown with respect to 20% V_{DD} and 80% V_{DD} thresholds, unless noted, as well as input signal transitions of 3 ns and a 30 pF maximum load on all SPI pins.

Table 61. SPI master mode timing on slew rate disabled pads

Num.	Symbol	Description	Min.	Max.	Unit	Note
1	f_{op}	Frequency of operation	$f_{periph}/2048$	$f_{periph}/2$	Hz	1
2	t_{SPSCK}	SPSCK period	$2 \times t_{periph}$	$2048 \times t_{periph}$	ns	2
3	t_{Lead}	Enable lead time	1/2	—	t_{SPSCK}	—
4	t_{Lag}	Enable lag time	1/2	—	t_{SPSCK}	—
5	t_{WSPSCK}	Clock (SPSCK) high or low time	$t_{periph} - 30$	$1024 \times t_{periph}$	ns	—
6	t_{SU}	Data setup time (inputs)	18	—	ns	—
7	t_{HI}	Data hold time (inputs)	0	—	ns	—
8	t_v	Data valid (after SPSCK edge)	—	15	ns	—
9	t_{HO}	Data hold time (outputs)	0	—	ns	—
10	t_{RI}	Rise time input	—	$t_{periph} - 25$	ns	—
	t_{FI}	Fall time input				
11	t_{RO}	Rise time output	—	25	ns	—
	t_{FO}	Fall time output				

1. For SPI0 f_{periph} is the bus clock (f_{BUS}). For SPI1 f_{periph} is the system clock (f_{SYS}).

2. $t_{periph} = 1/f_{periph}$

Table 62. SPI master mode timing on slew rate enabled pads

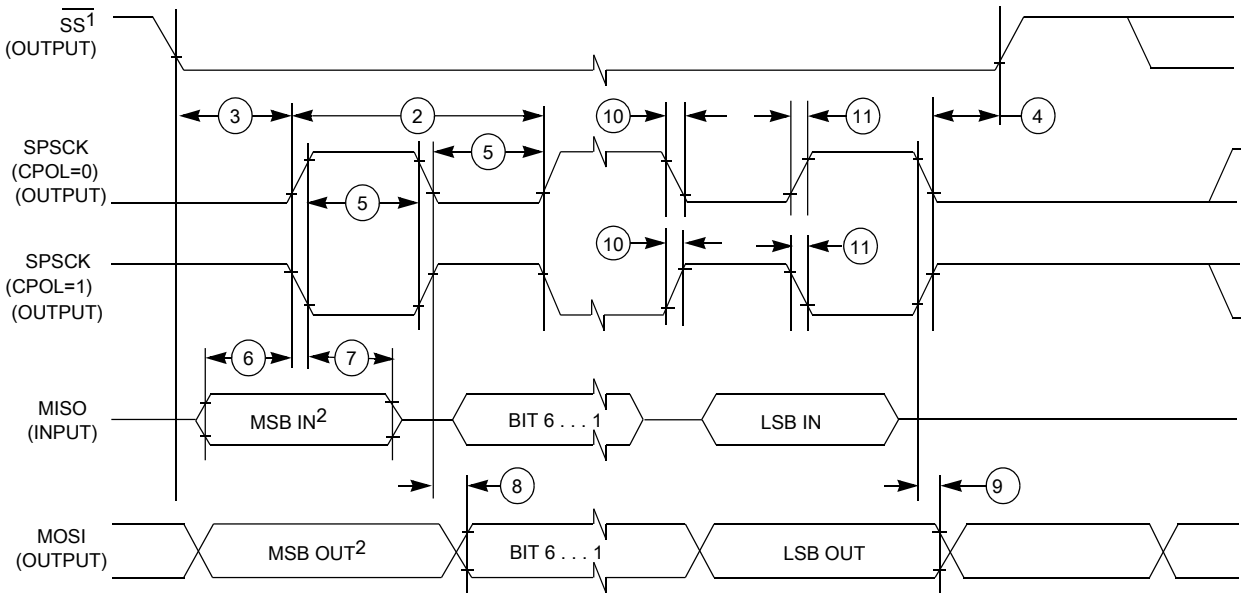
Num.	Symbol	Description	Min.	Max.	Unit	Note
1	f_{op}	Frequency of operation	$f_{periph}/2048$	$f_{periph}/2$	Hz	1
2	t_{SPSCK}	SPSCK period	$2 \times t_{periph}$	$2048 \times t_{periph}$	ns	2
3	t_{Lead}	Enable lead time	1/2	—	t_{SPSCK}	—
4	t_{Lag}	Enable lag time	1/2	—	t_{SPSCK}	—

Table continues on the next page...

Table 62. SPI master mode timing on slew rate enabled pads (continued)

Num.	Symbol	Description	Min.	Max.	Unit	Note
5	t_{WSPSCK}	Clock (SPSCK) high or low time	$t_{periph} - 30$	$1024 \times t_{periph}$	ns	—
6	t_{SU}	Data setup time (inputs)	96	—	ns	—
7	t_{HI}	Data hold time (inputs)	0	—	ns	—
8	t_V	Data valid (after SPSCK edge)	—	52	ns	—
9	t_{HO}	Data hold time (outputs)	0	—	ns	—
10	t_{RI}	Rise time input	—	$t_{periph} - 25$	ns	—
	t_{FI}	Fall time input				
11	t_{RO}	Rise time output	—	36	ns	—
	t_{FO}	Fall time output				

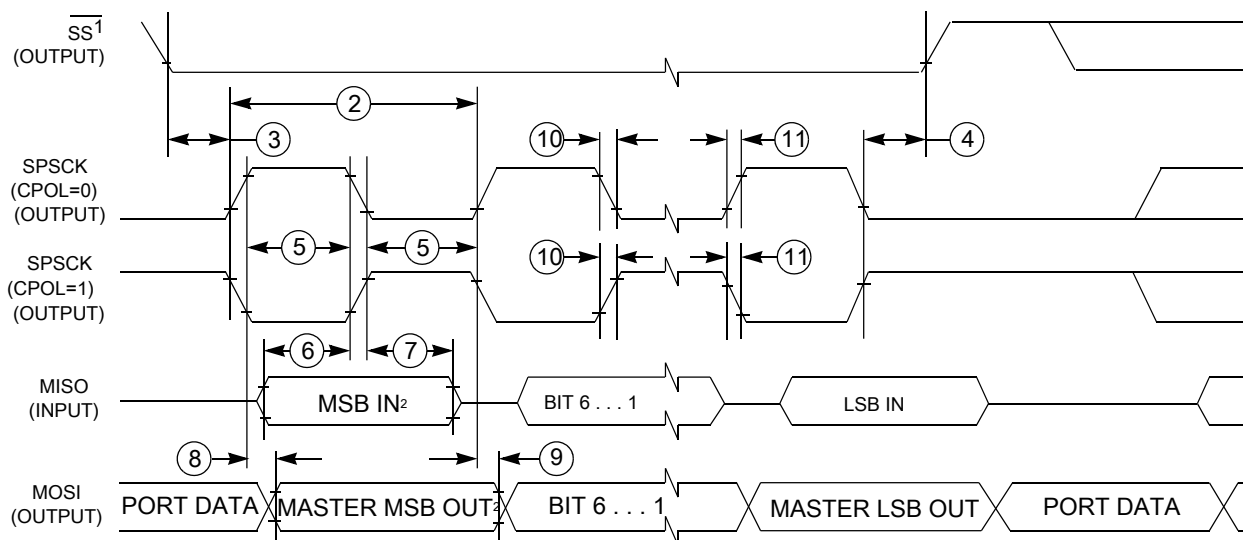
1. For SPI0 f_{periph} is the bus clock (f_{BUS}). For SPI1 f_{periph} is the system clock (f_{SYS}).
2. $t_{periph} = 1/f_{periph}$



1. If configured as an output.
2. LSBF = 0. For LSBF = 1, bit order is LSB, bit 1, ..., bit 6, MSB.

Figure 29. SPI master mode timing (CPHA = 0)

Electrical characteristics



1. If configured as output
2. LSBF = 0. For LSBF = 1, bit order is LSB, bit 1, ..., bit 6, MSB.

Figure 30. SPI master mode timing (CPHA = 1)

Table 63. SPI slave mode timing on slew rate disabled pads

Num.	Symbol	Description	Min.	Max.	Unit	Note
1	f_{op}	Frequency of operation	0	$f_{periph}/4$	Hz	1
2	t_{SPSCK}	SPSCK period	$4 \times t_{periph}$	—	ns	2
3	t_{Lead}	Enable lead time	1	—	t_{periph}	—
4	t_{Lag}	Enable lag time	1	—	t_{periph}	—
5	t_{WSPSCK}	Clock (SPSCK) high or low time	$t_{periph} - 30$	—	ns	—
6	t_{SU}	Data setup time (inputs)	2.5	—	ns	—
7	t_{HI}	Data hold time (inputs)	3.5	—	ns	—
8	t_a	Slave access time	—	t_{periph}	ns	3
9	t_{dis}	Slave MISO disable time	—	t_{periph}	ns	4
10	t_v	Data valid (after SPSCK edge)	—	31	ns	—
11	t_{HO}	Data hold time (outputs)	0	—	ns	—
12	t_{RI}	Rise time input	—	$t_{periph} - 25$	ns	—
	t_{FI}	Fall time input				
13	t_{RO}	Rise time output	—	25	ns	—
	t_{FO}	Fall time output				

1. For SPI0 f_{periph} is the bus clock (f_{BUS}). For SPI1 f_{periph} is the system clock (f_{SYS}).
2. $t_{periph} = 1/f_{periph}$
3. Time to data active from high-impedance state
4. Hold time to high-impedance state

2. The master mode I²C deasserts ACK of an address byte simultaneously with the falling edge of SCL. If no slaves acknowledge this address byte, then a negative hold time can result, depending on the edge rates of the SDA and SCL lines.
3. The maximum t_{HD; DAT} must be met only if the device does not stretch the LOW period (t_{LOW}) of the SCL signal.
4. Input signal Slew = 10 ns and Output Load = 50 pF
5. Set-up time in slave-transmitter mode is 1 IPBus clock period, if the TX FIFO is empty.
6. A Fast mode I²C bus device can be used in a Standard mode I²C bus system, but the requirement t_{SU; DAT} ≥ 250 ns must then be met. This is automatically the case if the device does not stretch the LOW period of the SCL signal. If such a device does stretch the LOW period of the SCL signal, then it must output the next data bit to the SDA line t_{rmax} + t_{SU; DAT} = 1000 + 250 = 1250 ns (according to the Standard mode I²C bus specification) before the SCL line is released.
7. C_b = total capacitance of the one bus line in pF.

To achieve 1MHz I2C clock rates, consider the following recommendations:

- To counter the effects of clock stretching, the I2C baud Rate select bits can be configured for faster than desired baud rate.
- Use high drive pad and DSE bit should be set in PORTx_PCRn register.
- Minimize loading on the I2C SDA and SCL pins to ensure fastest rise times for the SCL line to avoid clock stretching.
- Use smaller pull up resistors on SDA and SCL to reduce the RC time constant.

Table 66. I²C 1Mbit/s timing

Characteristic	Symbol	Minimum	Maximum	Unit
SCL Clock Frequency	f _{SCL}	0	1 ¹	MHz
Hold time (repeated) START condition. After this period, the first clock pulse is generated.	t _{HD; STA}	0.26	—	μs
LOW period of the SCL clock	t _{LOW}	0.5	—	μs
HIGH period of the SCL clock	t _{HIGH}	0.26	—	μs
Set-up time for a repeated START condition	t _{SU; STA}	0.26	—	μs
Data hold time for I ² C bus devices	t _{HD; DAT}	0	—	μs
Data set-up time	t _{SU; DAT}	50	—	ns
Rise time of SDA and SCL signals	t _r	20 + 0.1C _b	120	ns
Fall time of SDA and SCL signals	t _f	20 + 0.1C _b ²	120	ns
Set-up time for STOP condition	t _{SU; STO}	0.26	—	μs
Bus free time between STOP and START condition	t _{BUF}	0.5	—	μs
Pulse width of spikes that must be suppressed by the input filter	t _{SP}	0	50	ns

1. The maximum SCL clock frequency of 1 Mbit/s can support maximum bus loading when using the high drive pins across the full voltage range.
2. C_b = total capacitance of the one bus line in pF.

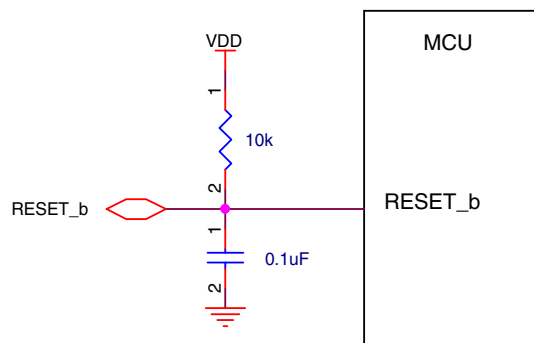


Figure 36. Reset circuit

When an external supervisor chip is connected to the RESET_b pin, a series resistor must be used to avoid damaging the supervisor chip or the RESET_b pin, as shown in the following figure. The series resistor value (R_S below) must be in the range of $100\ \Omega$ to $1\ \text{k}\Omega$ depending on the external reset chip drive strength. The supervisor chip must have an active high, open-drain output.

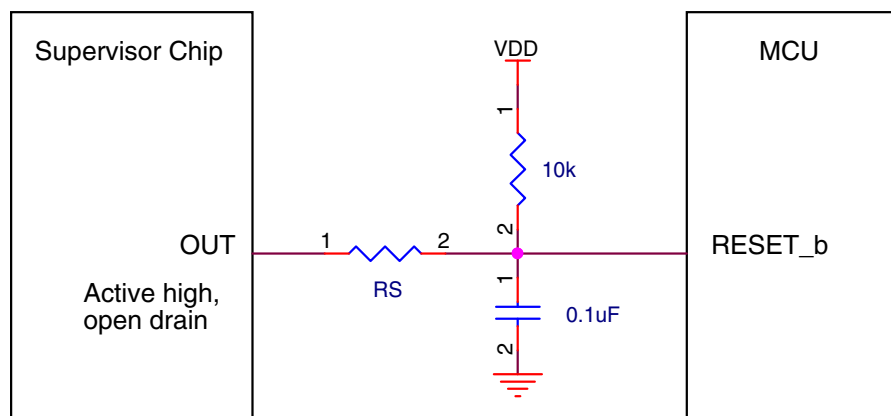


Figure 37. Reset signal connection to external reset chip

- NMI pin

Do not add a pull-down resistor or capacitor on the NMI_b pin, because a low level on this pin will trigger non-maskable interrupt. When this pin is enabled as the NMI function, an external pull-up resistor ($10\ \text{k}\Omega$) as shown in the following figure is recommended for robustness.

If the NMI_b pin is used as an I/O pin, the non-maskable interrupt handler is required to disable the NMI function by remapping to another function. The NMI function is disabled by programming the FOPT[NMI_DIS] bit to zero.